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|-----------------------------------|--|--|-------------------------|---|-------------|
| Notice of References Cited | | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | | 10/038,792 | KLINE ET AL. | |
| | | | Examiner | Art Unit | Page 1 of 1 |
| | | | Mark A Osele | 1734 | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,554,044 | 04-2003 | Paulson et al. | 156/540 |
| | B | US-6,500,291 | 12-2002 | Okada et al. | 156/230 |
| | C | US-4,060,441 | 11-1977 | Ohta et al. | 156/234 |
| | D | US-6,110,316 | 08-2000 | Kobayashi et al. | 156/230 |
| | E | US-6,022,429 | 02-2000 | Hagstrom, Erick | 156/64 |
| | F | US-6,585,366 | 07-2003 | Nagata et al. | 347/101 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|--------------|----------------|
| | N | 2000-313097 | 11-2000 | Japan | Okada et al. | --- |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

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